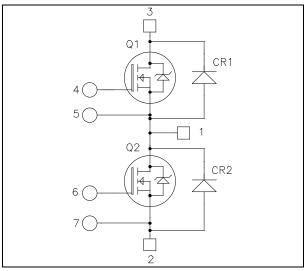
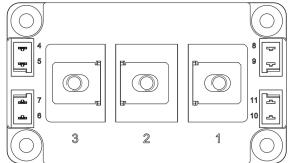


# Phase leg SiC MOSFET Power Module

 $V_{DSS} = 1200V$   $R_{DSon} = 16m\Omega \text{ typ } @ \text{Tj} = 25^{\circ}\text{C}$   $I_D = 98A @ \text{Tc} = 25^{\circ}\text{C}$ 





#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- SiC Power MOSFET
  - High speed switching
  - Low R<sub>DS(on)</sub>
  - Ultra low loss

#### • SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin emitter for easy drive
- High level of integration
- AlN substrate for improved thermal performance
- M6 power connectors

#### **Benefits**

- Stable temperature behavior
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- RoHS Compliant

#### All ratings @ $T_i = 25$ °C unless otherwise specified

#### Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter	Max ratings	Unit	
$V_{ m DSS}$	Drain - Source Voltage		1200	V
T	Continuous Drain Current	$T_c = 25$ °C	131	
$I_{\rm D}$	Continuous Diam Current	$T_c = 80$ °C	98	Α
$I_{DM}$	Pulsed Drain current		262	
$V_{GS}$	Gate - Source Voltage		-10/25V	V
$R_{DSon}$	Drain - Source ON Resistance		20	mΩ
$P_{D}$	Maximum Power Dissipation	$T_c = 25^{\circ}C$	625	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

1 - 7



# icrosemi. APTMC120AM16CD3AG

#### **Electrical Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ , $V_{DS} = 120$			500	μA	
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		16	20	
		$I_{\rm D} = 100 A$	$T_j = 150$ °C		30	42	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 5mA$		1.7	2.2		V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				1.25	μA

#### **Dynamic Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$ V_{GS} = 0V $ $V_{DS} = 1000V $			4.75		
$C_{oss}$	Output Capacitance				0.4		nF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz	f = 1MHz		0.033		
$Q_{g}$	Total gate Charge	$V_{GS} = 0/+20V$			246		
$Q_{gs}$	Gate – Source Charge	$V_{Bus} = 800V$			54		nC
$Q_{gd}$	Gate – Drain Charge	$I_{\rm D} = 100 A$					
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -5/+20V$		20			
$T_{\rm r}$	Rise Time	$V_{\text{GS}} = 37/20 \text{ V}$ $V_{\text{Bus}} = 800 \text{ V}$		20			
$T_{d(off)}$	Turn-off Delay Time	- , ,	$I_D = 100A$ ; $T_J = 150$ °C $R_L = 8\Omega$ ; $R_{Gext} = 10\Omega$				ns
$T_{\mathrm{f}}$	Fall Time	$R_L = 8\Omega$ ; $R_{Gext} = 108$					
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$	$T_j = 150$ °C		2.2		mJ
E <sub>off</sub>	Turn off Energy	$I_{D} = 100A$ $R_{Gext} = 10\Omega$ $T_{j} = 150$ °C			1.25		111,)
$R_{Gint}$	Internal gate resistance				1.9		Ω
$R_{\text{thJC}}$	Junction to Case Thermal Resistance	e				0.20	°C/W

#### **Source - Drain diode ratings and characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
17	Diode Forward Voltage	$V_{GS} = -5V, I_{SD} = 50A$		3.3		V
$V_{\mathrm{SD}}$	Diode Folward Voltage	$V_{GS} = -2V, I_{SD} = 50A$		3.1		·
$t_{rr}$	Reverse Recovery Time	1004 17 517		40		ns
Q <sub>rr</sub>	Reverse Recovery Charge	$I_{SD} = 100A ; V_{GS} = -5V$ $V_{R} = 800V ; di_{F}/dt = 1750A/\mu s$		825		nC
$I_{rr}$	Reverse Recovery Current	γ <sub>R</sub> 500 γ , αιματ 175077 μ5		32		A



# Microsemi. APTMC120AM16CD3AG

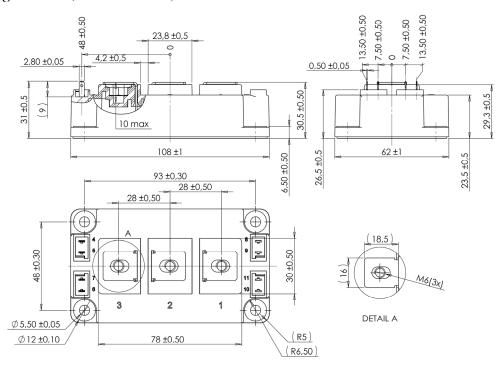
#### SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Condition	Min	Тур	Max	Unit	
$V_{RRM}$	Peak Repetitive Reverse Voltage					1200	V
т	Reverse Leakage Current	V -1200V	$T_j = 25$ °C		192	192 1200 336 6000	1
$I_{RRM}$		$V_{R}=1200V$	$T_{\rm j} = 175^{\circ}{\rm C}$		336		μA
$I_F$	DC Forward Current		Tc = 125°C		60		A
V	Diode Forward Voltage	$I_F = 60A$	$T_i = 25$ °C		1.6	1.8	V
$V_{\mathrm{F}}$	Diode Polward Voltage		$T_{i} = 175^{\circ}C$		2.3	3	
$Q_{\rm C}$	Total Capacitive Charge	$I_F = 60A, V_R = di/dt = 2400A/\mu$		480		nC	
С	Total Capacitance	$f = 1MHz, V_R =$	= 200V		576		рF
C	Total Capacitance	$f = 1 MHz, V_R = 800V$			414		pr
$R_{thJC}$	Junction to Case Thermal Resistance	e				0.19	°C/W

#### Thermal and package characteristics

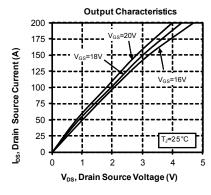
Symbol	Characteristic				Min	Max	Unit
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz						V
$T_{J}$	Operating unction temperature range		SiC	C MOSFET	-40	150	
1 J			SiC diode	-40	175		
$T_{JOP}$	Recommended junction temperature under switching conditions					T <sub>J</sub> max -25	°C
$T_{STG}$	Storage Temperature Range					125	
$T_{\rm C}$	Operating Case Temperature					100	
Torque	Maunting targue	For termin	als	M6	3	5	N.m
Torque	Mounting torque To Heatsi		nk	M6	3	5	18.111
Wt	Package Weight					350	g

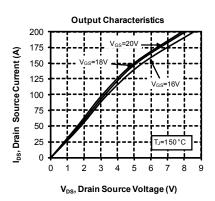
#### D3 Package outline (dimensions in mm)

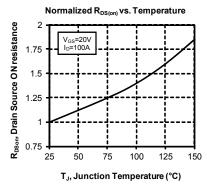


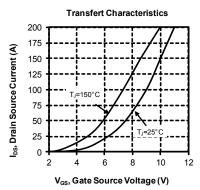


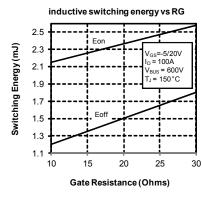
#### **Typical SiC MOSFET Performance Curve**

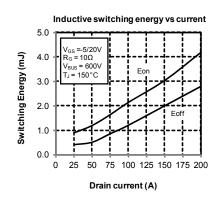


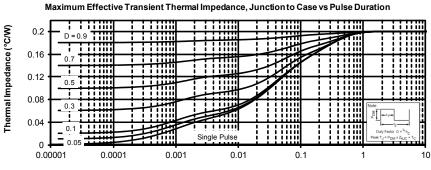








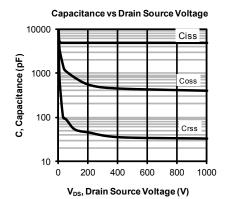


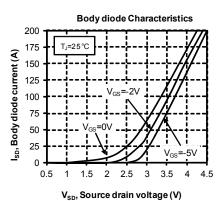


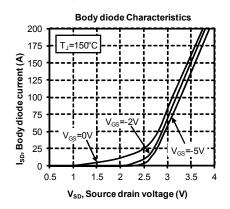
rectangular Pulse Duration (Seconds)

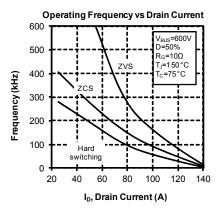
4 - 7

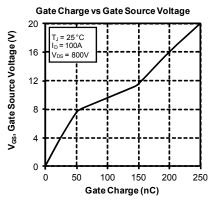


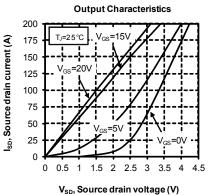


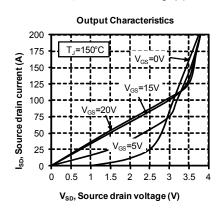










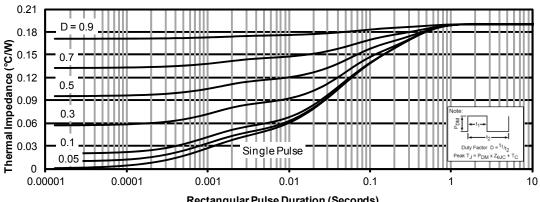




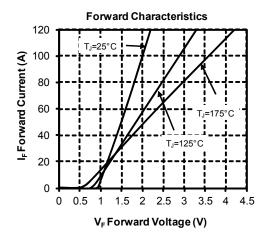
## Microsemi, APTMC120AM16CD3AG

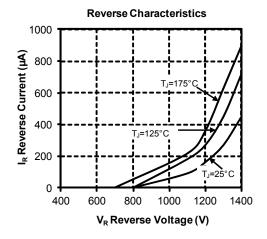
#### Typical SiC diode Performance Curve

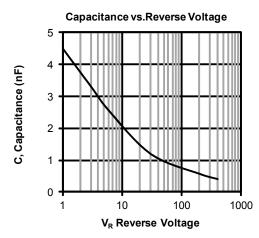
#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



Rectangular Pulse Duration (Seconds)







#### **DISCLAIMER**

The information contained in the document (unless it is publicly available on the Web without access restrictions) is PROPRIETARY AND CONFIDENTIAL information of Microsemi and cannot be copied, published, uploaded, posted, transmitted, distributed or disclosed or used without the express duly signed written consent of Microsemi. If the recipient of this document has entered into a disclosure agreement with Microsemi, then the terms of such Agreement will also apply. This document and the information contained herein may not be modified, by any person other than authorized personnel of Microsemi. No license under any patent, copyright, trade secret or other intellectual property right is granted to or conferred upon you by disclosure or delivery of the information, either expressly, by implication, inducement, estoppels or otherwise. Any license under such intellectual property rights must be approved by Microsemi in writing signed by an officer of Microsemi.

Microsemi reserves the right to change the configuration, functionality and performance of its products at anytime without any notice. This product has been subject to limited testing and should not be used in conjunction with life-support or other mission-critical equipment or applications. Microsemi assumes no liability whatsoever, and Microsemi disclaims any express or implied warranty, relating to sale and/or use of Microsemi products including liability or warranties relating to fitness for a particular purpose, merchantability, or infringement of any patent, copyright or other intellectual property right. Any performance specifications believed to be reliable but are not verified and customer or user must conduct and complete all performance and other testing of this product as well as any user or customers final application. User or customer shall not rely on any data and performance specifications or parameters provided by Microsemi. It is the customer's and user's responsibility to independently determine suitability of any Microsemi product and to test and verify the same. The information contained herein is provided "AS IS, WHERE IS" and with all faults, and the entire risk associated with such information is entirely with the User. Microsemi specifically disclaims any liability of any kind including for consequential, incidental and punitive damages as well as lost profit. The product is subject to other terms and conditions which can be located on the web at http://www.microsemi.com/legal/tnc.asp

#### Life Support Application

Seller's Products are not designed, intended, or authorized for use as components in systems intended for space, aviation, surgical implant into the body, in other applications intended to support or sustain life, or for any other application in which the failure of the Seller's Product could create a situation where personal injury, death or property damage or loss may occur (collectively "Life Support Applications").

Buyer agrees not to use Products in any Life Support Applications and to the extent it does it shall conduct extensive testing of the Product in such applications and further agrees to indemnify and hold Seller, and its officers, employees, subsidiaries, affiliates, agents, sales representatives and distributors harmless against all claims, costs, damages and expenses, and attorneys' fees and costs arising, directly or directly, out of any claims of personal injury, death, damage or otherwise associated with the use of the goods in Life Support Applications, even if such claim includes allegations that Seller was negligent regarding the design or manufacture of the goods.

Buyer must notify Seller in writing before using Seller's Products in Life Support Applications. Seller will study with Buyer alternative solutions to meet Buyer application specification based on Sellers sales conditions applicable for the new proposed specific part.

### **Mouser Electronics**

**Authorized Distributor** 

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Microsemi:

APTMC120AM16CD3AG